

LOGDAC **CMOS Logarithmic D/A Converter**

AD7118*

FEATURES

Dynamic Range 85.5dB Resolution 1.5dB

Full ±25V Input Range Multiplying DAC Full Military Temperature Range -55°C to +125°C

Low Distortion

Low Power Consumption

Latch Proof Operation (Schottky Diodes Not Required)

Single 5V to 15V Supply

APPLICATIONS

Digitally Controlled AGC Systems

Audio Attenuators

Wide Dynamic Range A/D Converters

Sonar Systems

Function Generators

GENERAL DESCRIPTION

The LOGDAC™ AD7118 is a CMOS multiplying D/A converter which attenuates an analog input signal over the range 0 to -85.5dB in 1.5dB steps. The analog output is determined by a six-bit attenuation code applied to the digital inputs. Operating frequency range of the device is from dc to several hundred kHz.

The device is manufactured using an advanced monolithic silicon gate thin-film on CMOS process and is packaged in a 14-pin dual-in-line package.

ORDERING GUIDE

| Model | Temperature Range | Specified Accuracy Range | Package Option ¹ | |
|-----------------------|----------------------|--------------------------------|--------------------------------|--|
| AD7118KN | 0 to +70°C | 0 to 42dB | N-16 | |
| AD7118LN | 0 to +70°C | 0 to 48dB | N-16 | |
| AD7118BQ | −25°C to +85°C | 0 to 42dB | Q-16 | |
| AD7118CQ | −25°C to +85°C | 0 to 48dB | Q-16 | |
| AD7118TQ ² | -55°C to +125°C | 0 to 42dB | Q-16 | |
| AD7118UQ ² | -55°C to +125°C | 0 to 48dB | Q-16 | |

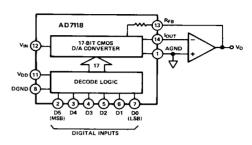
NOTES

¹N = Plastic DIP; Q = Cerdip. For outline information see Package Information section.

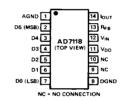
2To order MIL-STD-883, Class B processed parts, add /883B to part number.

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FUNCTIONAL DIAGRAM



PIN CONFIGURATION (Not to Scale)



$\textbf{AD7118} \textbf{---SPECIFICATIONS} \stackrel{(V_{DD}\ =\ +5V\ or\ +15V,\ V_{IN}\ =\ -10V\ dc,\ I_{OUT}\ =\ AGND\ =\ DGND\ =\ 0V,\ output}{\text{amplifier AD544 except where stated}}$

| PARAMETER | | TA = +25°C | | TA = Tmin, Tmax | | l | TEST CONDITIONS/ | |
|---|--|-----------------------|------------------------|----------------------|------------------------|----------------------------|---|--|
| | | $V_{DD} = +5V$ | V _{DD} = +15V | $V_{\rm DD} = +5V$ | V _{DD} ≈ +15V | UNITS | COMMENTS | |
| NOMINAL RESOLUTION | | 1.5 | 1.5 | 1.5 | 1.5 | dB | | |
| ACCURACY RELATIVE TO V AD7118L/C/U | IN | | | | ±0.4 | dB max | Accuracy is measured using | |
| 0 to -30dB -31.5 to -42dB -43.5 to -48dB | | ±0.35 ±0.7 ±1.0 | ±0.35 ±0.5 ±0.7 | ±0.4 ±0.8 ±1.3 | ±0.7 ±1.0 | dB max dB max | circuit of Figure 1 and includes any effects due to mismatch between RFR and the R-2R | |
| AD7118K/B/T 0 to -30dB -31.5 to -42dB | | ±0.5 ±0.75 | ±0.5 ±0.75 | ±0.5 ±1.0 | ±0.5 ±0.8 | dB max dB max | ladder circuit. | |
| MONOTONIC RANGE Nominal 1.5dB Steps | L/C/U Grade K/B/T Grade | Code Range | | 0 to -72 0 to -66 | 0 to -72 0 to -66 | dB dB | Digital Inputs 000000 to 110000 Digital Inputs 000000 to 101100 | |
| Nominal 3dB Steps | All Grades | Monotoni | c Over Full Code | | | | | |
| V _{IN} INPUT RESISTANCE (PIN 12) | All Grades L/C/U Grade K/B/T Grade | 9 17 21 | 9 17 21 | 9 17 21 | 9 17 21 | kΩ min kΩ max kΩ max | | |
| R _{FB} INPUT RESISTANCE (PIN 13) | All Grades L/C/U Grade K/B/T Grade | | 9,45 18 22 | 9.45 18 22 | 9,45 18 22 | kΩ min kΩ max kΩ max | | |
| DIGITAL INPUTS Input High Voltage Requirer Input Low Voltage Requirer Input Leakage Current | | 3.0 0.8 ±1 | 13.5 1.5 ±1 | 3.0 0.8 ±10 | 13.5 1.5 ±10 | V min V max μA max | Digital Inputs = V _{DD} | |
| POWER SUPPLY | | | i | Γ, | | V min | | |
| V _{DD} for Specified Accuracy | | 5 | 15 | 5 | 15 | V min V max | İ | |
| I_{DD} | | 0.5 | i | 1 | 2 | mA max | Digital Inputs = 0V or V _{DD} (See Figure 7) | |

Specifications subject to change without notice.

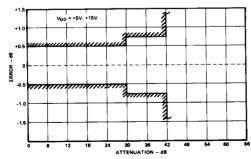
AC PERFORMANCE CHARACTERISTICS

These characteristics are included for design guidance only and are not subject to test.

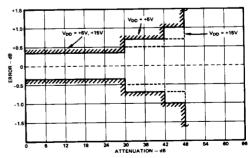
 $V_{DD} = +5V \text{ or } +15V, V_{IN} = -10V$ except where stated, $I_{OUT} = AGND = DGND = 0V$, output amplifier AD544 except where stated.

| | T _A = +25°C | | $T_A = T_{min}, T_{max}$ | |] | | |
|--|--|--|---|--|---|---|--|
| PARAMETER | $V_{DD} = +5V$ | V _{DD} = +15V | $v_{DD} = +15V$ $v_{DD} = +5V$ $v_{DD} = +15V$ | | UNITS | | |
| DC Supply Rejection, ΔGain/ΔV _{DD} | 0.01 | 0.005 | 0.01 | 0.005 | dB per % max | $\Delta V_{DD} = \pm 10\%$, Input code = 100000 | |
| Propagation Delay Digital to Analog Glitch Impulse | 1.8 225 | 0.4 1200 | 2.2 | 0.5 | μs max nV secs typ | Full Scale Change Measured with ADLH0032CG as output amplifier for input code transition 100000 to 000000. C1 of Figure 1 is OpF. | |
| Output Capacitance (Pin 14) Input Capacitance Pin 12 and Pin 13 Feedthrough at 1kHz L/C/U Grade K/B/T Grade Total Harmonic Distortion Intermodulation Distortion Output Noise Voltage Density Digital Input Capacitance | 100 7 -86 -80 -85 -79 70 | 100 7 -86 -80 -85 -79 70 | 100 7 -68 -63 -85 -79 70 7 | 100 7 -68 -63 -85 -79 70 | pF max pF max dB max dB max dB typ dB typ nV/√Hz max pF max | Feedthrough is also determined by circuit layout V _{IN} = 6V rms per DIN 45403 Blatt 4 Includes AD544 amplifier noise | |

Specifications subject to change without notice.



Accuracy Specification for K/B/T Grade Devices at $T_A = +25^{\circ} C$



Accuracy Specification for L/C/U Grade Devices at $T_A = +25^{\circ}C$

2-254 DIGITAL-TO-ANALOG CONVERTERS

REV. A

Applications Information—AD7118

ABSOLUTE MAXIMUM RATINGS*

 $(T_A = +25^{\circ}C \text{ unless otherwise noted})$

| $V^{}_{\mathbf{DD}}$ (to DGND) \hdots |
|--|
| V _{IN} (to AGND) |
| Digital Input Voltage to DGND0.3V to V _{DD} +0.3V |
| I _{OUT} to AGND |
| AGND to DGND 0 to V _{DD} |
| DGND to AGND 0 to V _{DD} |
| Power Dissipation (Any Package) |
| To +75°C |
| Derates Above +75°C by |

| Operating Temperature Range | |
|------------------------------|----------------|
| Commercial (K, L Versions) | 0 to +70°C |
| Industrial (B, C Versions) . | −25°C to +85°C |
| Extended (T, U Versions) . | 55°C to +125°C |
| Storage Temperature | 65°C to +150°C |
| Lead Temperature (Soldering, | 10 sec) +300°C |

*Stresses above those listed under "Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periodsmay affect device reliability.

CAUTION

ESD (electrostatic discharge) sensitive device. The digital control inputs are diode protected; however, permanent damage may occur on unconnected devices subject to high energy electrostatic fields. Unused devices must be stored in conductive foam or shunts. The protective foam should be discharged to the destination socket before devices are removed.



TERMINOLOGY

RESOLUTION: Nominal change in attenuation when moving between two adjacent binary codes.

MONOTONICITY: The device is monotonic if the analog output decreases (or remains constant) as the digital code increases.

FEEDTHROUGH ERROR: That portion of the input signal which reaches the output when all digital inputs are high. See section on Applications.

OUTPUT LEAKAGE CURRENT: Current which appears on the I_{OUT} terminal with all digital inputs high.

TOTAL HARMONIC DISTORTION: Is a measure of the harmonics introduced by the circuit when a pure sinusoid is applied to the input. It is expressed as the harmonic energy divided by the fundamental energy at the output.

ACCURACY: Is the difference (measured in dB) between the ideal transfer function as listed in Table 1 and the actual transfer function as measured with the device.

OUTPUT CAPACITANCE: Capacitance from IOUT to ground.

DIGITAL-TO-ANALOG GLITCH IMPULSE: The amount of charge injected from the digital inputs to the analog output when the inputs change state. This is normally specified as the area of the glitch in either pA-Secs or nV-Secs depending upon whether the glitch is measured as a current or voltage signal. Digital charge injection is measured with V_{IN} = AGND.

PROPAGATION DELAY: This is a measure of the internal delays of the circuit and is defined as the time from a digital input change to the analog output current reaching 90% of its final value.

INTERMODULATION DISTORTION: Is a measure of the interaction which takes place within the circuit between two sinusoids applied simultaneously to the input.

The reader is referred to Hewlett Packard Application Note 192 for further information.

CIRCUIT DESCRIPTION

GENERAL CIRCUIT INFORMATION

The AD7118 consists of a 17-bit R-2R CMOS multiplying D/A converter with extensive digital input logic. The logic translates the 6-bit binary input into a 17-bit word which is used to drive the D/A converter. Table I gives the nominal output voltages (and levels relative to 0dB = 10V) for all possible input codes. The transfer function for the circuit of Figure 1 is given by:

$$V_{O} = -V_{IN} \ 10 \ exp - \left\{ \frac{1.5N}{20} \right\}$$

or
$$|\frac{V_0}{V_{IN}}|_{dB} = -1.5N$$

where N is the binary input for values 0 to 57. For 60≤N≤63 the output is zero. See note 3 at bottom of Table 1.

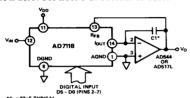


Figure 1. Typical Circuit Configuration

EQUIVALENT CIRCUIT ANALYSIS

Figure 2 shows a simplified circuit of the D/A converter section of the AD7118 and Figure 3 gives an approximate equivalent

The current source ILEAKAGE is composed of surface and junction leakages and as with most semiconductor devices, roughly doubles every 10°C-see Figure 10. The resistor RO as shown in Figure 3 is the equivalent output resistance of the device which varies with input code (excluding all 0's code) from 0.8R to 2R. R is typically 12kΩ. COUT is the capacitance due to the N channel switches and varies from about 50pF to 80pF depending upon the digital input. For further information on CMOS multiplying D/A converters refer to "Application Guide to CMOS Multiplying D/A Converters" which is available from Analog Devices, Publication Number G479-15-8/78.

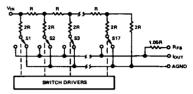


Figure 2. Simplified D/A Circuit of AD7118

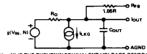


Figure 3. Equivalent Analog Output Circuit of AD7118

| N | Digital Input D5 D0 | Attenuation dB | V _{OUT} 1 | N | Digital Input | Attenuation | V _{OUT} ¹ |
|----|------------------------|-------------------|--------------------|----|-----------------------|-------------|-------------------------------|
| L | | | | | | | |
| 0 | 00 00 00 | 0.0 | 10.00 | 31 | 01 11 11 | 46.5 | 0.0473 |
| 1 | 00 00 01 | 1.5 | 8.414 | 32 | 10 00 00 | 48.0 | 0.0398 |
| 2 | 00 00 10 | 3.0 | 7.079 | 33 | 10 00 01 | 49.5 | 0.0335 |
| 3 | 00 00 11 | 4.5 | 5.957 | 34 | 10 00 10 | 51.0 | 0.0282 |
| 4 | 00 01 00 | 6.0 | 5.012 | 35 | 10 00 11 | 52.5 | 0.0237 |
| 5 | 00 01 01 | 7.5 | 4.217 | 36 | 10 01 00 | 54.0 | 0.0200 |
| 6 | 00 01 10 | 9.0 | 3.548 | 37 | 10 01 01 | 55.5 | 0.0168 |
| 7 | 00 01 11 | 10.5 | 2.985 | 38 | 10 01 10 | 57.0 | 0.0141 |
| 8 | 00 10 00 | 12.0 | 2.512 | 39 | 10 01 11 | 58.5 | 0.0119 |
| 9 | 00 10 01 | 13.5 | 2.113 | 40 | 10 10 00 | 60.0 | 0.0100 |
| 10 | 00 10 10 | 15.0 | 1.778 | 41 | 10 10 01 | 61.5 | 0.00841 |
| 11 | 00 10 11 | 16.5 | 1.496 | 42 | 10 10 10 | 63.0 | 0.00708 |
| 12 | 00 11 00 | 18.0 | 1.259 | 43 | 10 10 11 | 64.5 | 0.00596 |
| 13 | 00 11 01 | 19.5 | 1.059 | 44 | 10 11 00 | 66.0 | 0.00501 |
| 14 | 00 11 10 | 21.0 | 0.891 | 45 | 10 11 01 | 67.5 | 0.00422 |
| 15 | 00 11 11 | 22.5 | 0.750 | 46 | 10 11 10 | 69.0 | 0.00355 |
| 16 | 01 00 00 | 24.0 | 0.631 | 47 | 10 11 11 | 70.5 | 0.00299 |
| 17 | 01 00 01 | 25.5 | 0.531 | 48 | 11 00 00 | 72.0 | 0.00251 |
| 18 | 01 00 10 | 27.0 | 0.447 | 49 | 11 00 01 | 73.5 | 0.00211 |
| 19 | 01 00 11 | 28.5 | 0.376 | 50 | 11 00 10 | 75.0 | 0.00178 |
| 20 | 01 01 00 | 30.0 | 0.316 | 51 | 11 00 11 | 76.5 | 0.00150 |
| 21 | 01 01 01 | 31.5 | 0.266 | 52 | 11 01 00 | 78.0 | 0.00126 |
| 22 | 01 01 10 | 33.0 | 0.224 | 53 | 11 01 01 | 79.5 | 0.00106 |
| 23 | 01 01 11 | 34.5 | 0.188 | 54 | 11 01 10 | 81.0 | 0.000891 |
| 24 | 01 10 00 | 36.0 | 0.158 | 55 | 11 01 11 | 82.5 | 0.000750 |
| 25 | 01 10 01 | 37.5 | 0.133 | 56 | 11 10 00 | 84.0 | 0.000631 |
| 26 | 01 10 10 | 39.0 | 0.112 | 57 | 11 10 01 | 85.5 | 0.000531 |
| 27 | 01 10 11 | 40.5 | 0.0944 | | 1 11 10 01 | 0,0 | 0.000771 |
| 28 | 01 11 00 | 42.0 | 0.0794 | | | | |
| 29 | 01 11 01 | 43.5 | 0.0668 | | | | |
| 30 | 01 11 10 | 45.0 | 0.0562 | 60 | 11 11 XX ² | ∞ | |

NOTES

Table I. Ideal Attenuation vs. Input Code

V_{IN} = -10V dc

² X = 1 or 0. Output is fully muted for N≥60

³ Monotonic operation is not guaranteed for N = 58, 59

Applications Information—AD7118

DYNAMIC PERFORMANCE

The dynamic performance of the AD7118 will depend upon the gain and phase characteristics of the output amplifier, together with the optimum choice of PC board layout and decoupling components. Figure 4 shows a printed circuit layout which minimizes feedthrough from $V_{\rm IN}$ to the output in multiplying applications. Circuit layout is most important if the optimum performance of the AD7118 is to be achieved. Most application problems stem from either poor layout, grounding errors, or inappropriate choice of amplifier.

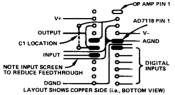


Figure 4. Suggested Layout for AD7118 and Op Amp

It is recommended that when using the AD7118 with a high speed amplifier, a capacitor C1 be connected in the feedback path as shown in Figure 1. This capacitor, which should be between 30pF and 50pF, compensates for the phase lag introduced by the output capacitance of the D/A converter. Figures 5 and 6 show the performance of the AD7118 using the AD517, a fully compensated high gain superbeta amplifier, and the AD544, a fast FET input amplifier. The performance without C1 is shown in the middle trace and the response with C1 in circuit is shown in the bottom trace.

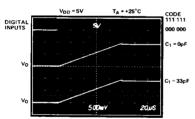


Figure 5. Response of AD7118 with AD517L

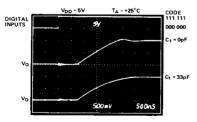


Figure 6. Response of AD7118 with AD544S

In conventional CMOS D/A converter design parasitic capacitance in the N-channel D/A converter switches can give rise to glitches on the D/A converter output. These glitches result from digital feedthrough. The AD7118 has been designed to minimize these glitches as much as possible. It is recommended that for minimum glitch energy the AD7118 be operated with $V_{\rm DD} = 5 V$. This will reduce the available energy for coupling

across the parasitic capacitance. It should be noted that the accuracy of the AD7118 improves as V_{DD} is increased (see Figure 8) but the device maintains monotonic behavior to at least -66dB in the range $5 \leq V_{DD} \leq 15$ volts.

For operation beyond 250kHz, capacitor C1 may be reduced in value. This gives an increase in bandwidth at the expense of a poorer transient response as shown in Figures 6 and 11. In circuits where C1 is not included the high frequency roll-off point is primarily determined by the characteristics of the output amplifier and not the AD7118.

Feedthrough and absolute accuracy for attenuation levels beyond 42dB are sensitive to output leakage current effects. For this reason it is recommended that the operating temperature of the AD7118 be kept as close to 25°C as is practically possible, particularly where the device's performance at high attenuation levels is important. A typical plot of leakage current vs. temperature is shown in Figure 10.

Some solder fluxes and cleaning materials can form slightly conductive films which cause leakage effects between analog input and output. The user is cautioned to ensure that the manufacturing process for circuits using the AD7118 does not allow such films to form. Otherwise the feedthrough, accuracy and maximum usable range will be affected.

STATIC ACCURACY PERFORMANCE

The D/A converter section of the AD7118 consists of a 17-bit R-2R type converter. To obtain optimum static performance at this level of resolution it is necessary to pay great attention to amplifier selection, circuit grounding, etc.

Amplifier input bias current results in a dc offset at the output of the amplifier due to the current flowing through the feedback resistor R_{FB}. It is recommended that an amplifier with an input bias current of less than 10nA be used (e.g., AD517 or AD544) to minimize this offset.

Another error arises from the output amplifier's input offset voltage. The amplifier is operated with a fixed feedback resistance, but the equivalent source impedance (the AD7118 output impedance) varies as a function of attenuation level. This has the effect of varying the "noise" gain of the amplifier, thus creating a varying error due to amplifier offset voltage. To achieve an output offset error less than one half the smallest step size, it is recommended that an amplifier with less than $50\mu V$ of input offset be used (such as the AD517 or AD OP-07).

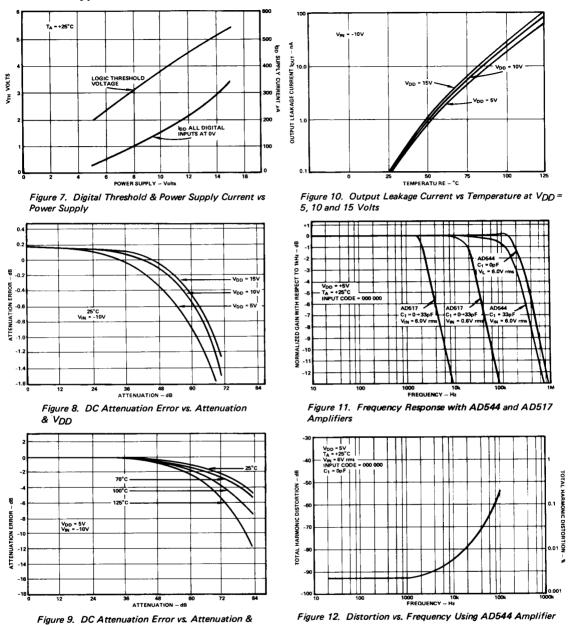
If dc accuracy is not critical in the application, it should be noted that amplifiers with offset voltage up to approximately 2 millivolts can be used. Amplifiers with higher offset voltage may cause audible "thumps" due to dc output changes.

The AD7118 accuracy is specified and tested using only the internal feedback resistor. It is not recommended that "gain" trim resistors be used with the AD7118 because the internal logic of the circuit executes a proprietary algorithm which approximates a logarithmic curve with a binary D/A converters as a result no single point on the attenuator transfer function can be guaranteed to lie exactly on the theoretical curve. Any "gain-error" (i.e., mismatch of RFB to the R-2R ladder) that may exist in the AD7118 D/A converter circuit results in a constant attenuation error over the whole range. Since the gain-error of CMOS multiplying D/A converters is normally less than 1%, the accuracy error contribution due to "gain-error" effects is normally less than 0.09dB.

REV. A

DIGITAL-TO-ANALOG CONVERTERS 2-257

AD7118—Typical Performance Characteristics



Temperature